

<b>Notice of References Cited</b>	Application/Control No. 10/791,798	Applicant(s)/Patent Under Reexamination CHOI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,697,514	02-2004	Kobayashi et al.	382/141
	B	US-6,590,643	07-2003	Kubota et al.	356/121
	C	US-5,790,247	08-1998	Henley et al.	356/237.1
	D	US-5,734,158	03-1998	Nagashima et al.	250/225
	E	US-5,696,550	12-1997	Aoki et al.	348/125
	F	US-5,349,190	09-1994	Hines et al.	250/363.05
	G	US-4,989,981	02-1991	Kawamura et al.	356/394
	H	US-4,870,357	09-1989	Young et al.	324/770
	I	US-4,629,319	12-1986	Clarke et al.	356/237.2
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2669180 A1	05-1992	France	FRANCIS et al.	G03B 15/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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